Contact and Fees		
X-ray Diffraction Facility and Solid State Characterization Core Lab		
USF Department of Chemistry		
USF Research Park		
3720 Spectrum Blvd, IDRB 211B,		
Tampa, FL 33612		

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USF ACADEMIC USERS						
Service	FEE [\$/HR]	Typical charge for one sample (may vary depending on sample / range)				
Single Crystal Diffractometer (SCXRD) Please see the second page for co-authorship policy	20	\$60-\$240				

The following guidelines should be used to determine ray crystallographer should be included as a co-author for a publication or if an acknowledgement is sufficient uses guidelines are in accord with recommendations from the American Crystallograph ssociation and consistent with -authorship guidelines set forth by most academic journals.

## Crystallographer should becludedasa coauthorif:

- structural information derived from the -Xay diffraction experiment is a critical paoff the intellectual content of the papeand the structural information has been derived mainly from the diffraction data
- structural dataand modelsbeing published requiresignificantinput from crystallographer and use of crystallographer'expertise in data processing, modeling **and**lysis of results